Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination MARUNO ET AL. Examiner Art Unit Pritham Prabhakher 2622 Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|-------------------------|----------------|
| * | Α | US-5,798,791 | 08-1998 | Katayama et al. | 348/218.1 |
| * | В | US-6,760,062 B2 | 07-2004 | Ostromek et al. | 348/211.11 |
| * | ပ | US-2002/0171741 A1 | 11-2002 | Tonkin et al. | 348/211.3 |
| * | D | US-5,757,423 | 05-1998 | Tanaka et al. | 348/218.1 |
| * | Ε | US-7,136,094 B2 | 11-2006 | Ziemkowski, Theodore B. | 348/211.1 |
| * | F | US-6,762,794 B1 | 07-2004 | Ogino, Shigeru | 348/262 |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | · | |
| | Р | | | | | • |
| | Q | | | | | |
| | R | , | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | υ | |
| | > | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.